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(71) Applicant (*for all designated States except US*): **UNIVERSITY-INDUSTRY COOPERATION GROUP OF KYUNGHEE UNIVERSITY** [KR/KR]; 1 Seocheon-dong, Giheung-gu, Yongin-si, Gyeonggi-do, 446-701 (KR).

(72) Inventors; and

(75) Inventors/Applicants (*for US only*): **KWON, Oh In** [KR/KR]; 112-1502, Hansin-Chunggu Apt., Mok 6-dong, Yangcheon-gu, Seoul, 158-751 (KR). **WOO, Eung Je** [KR/KR]; 106-104, Samick Villa, 121 Gumi-dong, Bundang-gu, Seongnam-si, Gyeonggi-do, 463-500 (KR).

PARK, Chun Jae [KR/KR]; 109-401, Daelim Gangbyeontown Apt., Eunghong-dong, Seongdong-gu, Seoul, 133-769 (KR). **NAM, Hyun Soo** [KR/KR]; 102-906, Gabeulmyeongga, 458 Sangdo-dong, Dongjak-gu, Seoul, 156-030 (KR).

(74) Agents: **KIM, Yong In** et al.; KBK & Associates, 15th Floor, YoSam Building, 648-23, Yeoksam-dong, Kangnam-ku, Seoul, 135-748 (KR).

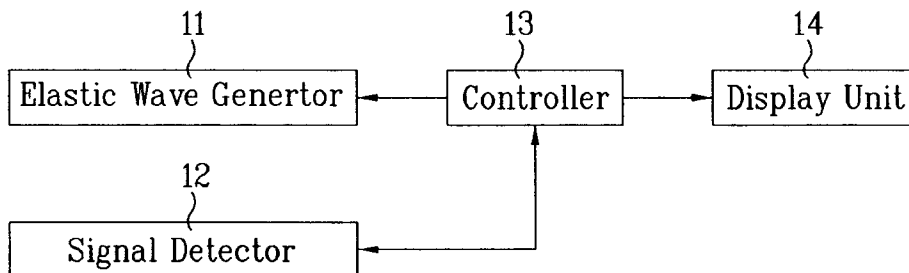
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[Continued on next page]

(54) Title: APPARATUS AND METHOD FOR IMAGING SHEAR MODULUS WITHIN A BODY

FIG. 1



(57) Abstract: An apparatus and method for imaging a shear modulus within a body is disclosed. A method for imaging a shear modulus in accordance with the present invention includes generating an elastic wave inside an object to be measured; detecting the elastic wave ongoing inside the object to be measured; calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time; and imaging the inside of the object to be measured, based on the calculated shear modulus.

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TITLE OF INVENTION

APPARATUS AND METHOD FOR IMAGING SHEAR MODULUS WITHIN A BODY

5 FIELD OF THE INVENTION

The present invention relates to an apparatus and method for imaging the inside of an object to be measured, by using an elastic wave.

DISCUSSION OF THE RELATED ART

10 Generally, X-rays, magnetic resonance imaging (MRI), and supersonic waves have been used to image an inner structure of a body or an object. New medical imaging methods have been developed to overcome limitation of the existing medial imaging field.

For example, a method for imaging a shear modulus within a body has
15 been developed. According to this method, a wave generator, which generates a shear wave, is attached to a surface of a body, and the shear wave generated within the body through the wave generator is measured using MRI. Afterwards, the shear modulus within the body is imaged using displacement of the measured shear wave.

20 It is known that a cancer tissue within the body has a shear modulus different from a normal tissue due to its variable physical properties. Such a variation of physical properties is imaged using displacement of the shear wave that can be measured using MRI equipment, whereby many studies for new medical imaging are being made actively.

However, considering that the measured shear wave displacement data include noise, various shear modulus imaging methods, which have been conventionally developed, have a drawback in that it is difficult to image a real wrong tissue due to amplified noise.

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SUMMARY OF THE INVENTION

Accordingly, the present invention is directed to an apparatus and method for imaging a shear modulus within a body, which substantially obviates one or more problems due to limitations and disadvantages of the related art.

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An object of the present invention is to provide an apparatus and method for imaging a shear modulus within a body, in which the inside of an object to be measured can exactly be imaged using an elastic wave.

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Additional advantages, objects, and features of the invention will be set forth in part in the description which follows and in part will become apparent to those having ordinary skill in the art upon examination of the following or may be learned from practice of the invention. The objectives and other advantages of the invention may be realized and attained by the structure particularly pointed out in the written description and claims hereof as well as the appended drawings.

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To achieve these objects and other advantages and in accordance with the purpose of the invention, as embodied and broadly described herein, a method for imaging a shear modulus in accordance with the present invention includes generating an elastic wave inside an object to be measured; detecting the elastic wave ongoing inside the object to be

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measured; calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time; and imaging the inside of the object to be measured, based on the calculated shear modulus.

5 The step of calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time includes calculating an irrotational component and a solenoidal component of a stress vector from the detected elastic wave; and calculating the shear modulus of the inside of the object to be
10 measured, using the calculated irrotational component, the calculated solenoidal component, and the value obtained by differentiating the detected elastic wave one time.

 The step of calculating an irrotational component and a solenoidal component from the detected elastic wave includes calculating the
15 irrotational component using one directional component value of the detected elastic wave and a frequency of the elastic wave; and calculating the solenoidal component based on the calculated irrotational component and the value obtained by differentiating the detected elastic wave one time.

20 In the step of calculating the shear modulus of the inside of the object to be measured, using the calculated irrotational component, the calculated solenoidal component, and the value obtained by differentiating the detected elastic wave one time, the solenoidal component approximate to an actual value is calculated by applying the calculated irrotational

component and the value obtained by differentiating the detected elastic wave one time to an iteration algorithm.

In another aspect of the present invention, an apparatus for imaging a shear modulus includes an elastic wave generator generating an elastic wave inside an object to be measured; a signal detector detecting the elastic wave ongoing inside the object to be measured; and a controller calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time, and imaging the inside of the object to be measured, based on the calculated shear modulus.

The signal detector is MRI equipment or a supersonic measurement device.

It is to be understood that both the foregoing general description and the following detailed description of the present invention are exemplary and explanatory and are intended to provide further explanation of the invention as claimed.

BRIEF DESCRIPTION OF THE DRAWINGS

The accompanying drawings, which are included to provide a further understanding of the invention and are incorporated in and constitute a part of this application, illustrate embodiment(s) of the invention and together with the description serve to explain the principle of the invention. In the drawings:

FIG. 1 illustrates an apparatus for imaging a shear modulus in accordance with the present invention; and

FIG. 2 illustrates a part of an apparatus for imaging a shear modulus in accordance with the present invention.

DETAILED DESCRIPTION OF THE INVENTION

5 Reference will now be made in detail to the preferred embodiments of the present invention, examples of which are illustrated in the accompanying drawings. Wherever possible, the same reference numbers will be used throughout the drawings to refer to the same or like parts.

Hereinafter, the preferred embodiments of the present invention will
10 be described with reference to the accompanying drawings.

FIG. 1 illustrates an apparatus for imaging a shear modulus in accordance with the present invention. FIG. 1 illustrates only elements required to describe the subject matter of the present invention. As shown in FIG. 1, the apparatus for imaging a shear modulus in accordance with
15 the present invention includes an elastic wave generator 11 providing an elastic wave into an object to be measured, a signal detector 12 detecting the elastic wave ongoing inside the object, a controller 13 outputting image data based on the signal detected from the signal detector 12, and a display unit 14 displaying the image data output from the controller 13.

20 The elastic wave includes a longitudinal wave and a transverse wave. The longitudinal wave (compressed wave) is generated due to bulk modulus accompanied with bulk change caused by oscillation displacement of an elastic medium in parallel with an ongoing direction of the wave. The transverse wave (shear wave) is generated due to form change caused by
25 oscillation displacement of an elastic medium vertically with an ongoing

direction of the wave. In this case, the elastic wave provided into the object to be measured by the elastic wave generator 11 is a shear wave. A shear wave generator or a supersonic generator is used as the elastic wave generator 11.

5 A method for imaging the inside of the object to be measured using the aforementioned imaging apparatus will be described below.

First of all, the elastic wave generator 11 generates an elastic wave of a frequency (ω) set under the control of the controller 13, and provides the generated elastic wave to a surface of the object to be
10 measured. The elastic wave provided into the object to be measured and ongoing therein is detected by the signal detector 12.

An MRI scanner or a supersonic measurement device can be used as the signal detector 12. For example, if the MRI scanner is used as the signal detector 12, the object to be measured can be scanned by a large-scaled
15 MRI scanner in a non-contact state to measure the elastic wave ongoing inside the object to be measured. If a small-scaled supersonic measurement device is used as the signal detector 12, it is preferable that a part of the object S to be measured is located on a virtual straight line which connects the elastic wave generator 11 with the supersonic measurement
20 device 12 as shown in FIG. 2, and is in contact with the supersonic measurement device 12.

The signal detected by the signal detector 12 is transmitted to the controller 13, and the controller 13 outputs image data that can image the inside of the object S to be measured, based on the detected signal.

A method for generating image data based on the detected signal is as follows. The present invention suggests two methods for generating image data based on the detected elastic wave signal.

First method

5 An elastic wave signal (elastic displacement) $U=(U_x, U_y, U_z)$ detected by the signal detector 12 is expressed in a frequency domain under the assumption of isotropy and linearity of a medium in the form of a partial differential equation such as the following equation 1.

[Equation 1]

$$10 \quad \nabla \cdot (\mu \nabla \mathbf{u}) + \nabla ((\lambda + \mu) \nabla \cdot \mathbf{u}) + \rho \omega^2 \mathbf{u} = 0$$

In the equation 1, λ represents a longitudinal modulus or a bulk modulus of an object to be measured, and μ represents a transverse modulus or a shear modulus of an object to be measured. Also, ω represents a frequency of the elastic wave.

15 In order to apply the Equation 1 to an algorithm of the present invention, supposing incompressibility having no bulk change of the object to be measured, due to a given force, the equation 1 satisfies the following equation 2.

[Equation 2]

$$20 \quad \nabla \cdot \mu \nabla U + \omega^2 U = 0$$

To image the inside of the object to be measured, it is necessarily required to recover the shear modulus μ from the measured elastic wave signal $U=(U_x, U_y, U_z)$. To induce an equation for obtaining the shear modulus

μ , it is supposed that the shear modulus μ is a constant. Under such assumption, the equation 2 can be expressed in a simpler form such as the following equation 3.

[Equation 3]

$$\mu \nabla^2 U + \omega^2 U = 0$$

The shear modulus μ of U_z , which is one of components of the measured elastic wave signal, is expressed by the following equation 4 using the equation 3.

[Equation 4]

$$\mu = -\frac{\omega^2 U_z}{\nabla^2 U_z}$$

As expressed by the equation 4, the shear modulus μ according to the first method has a great negative value if the frequency ω of the elastic wave becomes great but has a small negative value if the elastic wave signal U_z differentiated twice becomes great.

The controller 13 calculates the shear modulus μ from the measured elastic wave signal $U=(U_x, U_y, U_z)$ by using the equation 4, generates image data based on the measured elastic wave signal $U=(U_x, U_y, U_z)$ and the calculated shear modulus μ , and outputs the generated image data to the display unit 14. It will be apparent that generating image data based on the measured elastic wave signal $U=(U_x, U_y, U_z)$ and the calculated shear modulus μ can be carried out by various methods. In this case, the calculated shear modulus μ represents a modulus of body tissues inside the object to be measured. Since the respective tissues have different

moduli, the image data generated based on the shear modulus μ can image the inside of the object to be measured.

Second method

Since the first method differentiates the measured elastic wave
 5 signal U_z twice, a value of noise included in the elastic wave signal may also be differentiated twice. In other words, if noise is included in the elastic wave signal, the value of noise can be amplified as much as differentiation of twice. The second method is to minimize such amplification of noise.

10 When the Equation 2 is expressed by an equation of a z-directional component U_z of the measure elastic wave signal, the following equation 5 can be obtained.

[Equation 5]

$$\nabla \cdot \mu \nabla U_z + \omega^2 U_z = 0$$

15 In the equation 5, the stress part $\mu \nabla U_z$ in the simplified equation including an unfixed parameter μ can be expressed by the following equation 6 in accordance with Helmholtz decomposition.

[Equation 6]

$$\mu \nabla U_z = \nabla f + \nabla \times W$$

20 In other words, the vector field $\mu \nabla U_z$ is divided into an irrotational component and a solenoidal component in accordance with

Helmholtz decomposition. In this case, the irrotational component represents a gradient value of scalar potential f , and the solenoidal component represents a curl value of vector potential W .

Also, the equation 6 can be substituted for the equation 5 to obtain the following equation 7.

[Equation 7]

$$\nabla \cdot (\nabla f + \nabla \times W) + \omega^2 U_z = 0$$

The equation 7 can be expressed as follows to obtain the scalar potential f .

10 [Equation 8]

$$\nabla^2 f = -\omega^2 U_z$$

In the equation 8, since a value of a right side represents a set frequency and the measured elastic wave signal, a function value of the scalar potential f can be obtained using the equation 8. A gradient component of a stress vector can be obtained using the obtained potential f , and if the curl value of the vector potential W of the solenoidal component is disregarded, an equation that can obtain the shear modulus μ can be induced using the equation 6. For example, if the vector product of ∇U_z is taken at both sides of the equation 6, the following equation 9

15

20 can be obtained.

[Equation 9]

$$\mu \nabla U_z \cdot \nabla U_z = \nabla f \cdot \nabla U_z + \nabla \times W \cdot \nabla U_z$$

If the equation 9 is arranged to recover the curl component repeatedly, the following equation 10 for obtaining the shear modulus μ can be induced.

[Equation 10]

$$\mu^{n+1} = \frac{\nabla f \cdot \nabla U_z + \nabla \times W^n \cdot \nabla U_z}{\nabla U_z \cdot \nabla U_z} \quad n=0,1,2,3...$$

5

The equation 10 is for an iteration algorithm which obtains the most approximate value in a repeated manner. Since the function value of f is calculated through the equation 8 and U_z is the measured value, a value of the shear modulus μ can be obtained if $\nabla \times W^n$ is obtained.

10

After elastic displacement U_z^n corresponding to a shear modulus μ^n which is improved repeatedly is calculated, a divergence-free part of $\mu^n U_z^n$ can be obtained by calculation.

[Equation 11]

$$\mu^n \nabla U_z^n = \nabla f^n + \nabla \times W^n$$

15

[Equation 12]

$$\nabla \cdot (\mu^n \nabla U_z^n) + \omega^2 U_z^n = 0$$

For example, after U_z^n is calculated using the equation 12, a value of $\nabla \times W^n$ for the shear modulus μ^n is calculated using the equation 11. Subsequently, if the calculated value of $\nabla \times W^n$ is substituted for the equation 10, a shear modulus μ^{n+1} can be obtained.

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The shear modulus μ^{n+1} is substituted for the equation 11 to calculate $\nabla \times W^{n+1}$, and the calculated value of $\nabla \times W^{n+1}$ is substituted for the equation 10 to calculate a shear modulus μ^{n+2} . In this case, the shear modulus becomes more approximate to the actual shear modulus if the value of n increases.

In case of an anisotropic modulus, if μ is expressed by 3x3 matrix, for example, after the elastic displacements U_x , U_y , U_z in three directions are measured, f_x , f_y , f_z with respect to the respective directions are respectively obtained using the equation 8. If W is equal to 0, the following equation 13 can be obtained using the equation 6.

[Equation 13]

$$\mu [\nabla U_x, \nabla U_y, \nabla U_z] = [\nabla f_x, \nabla f_y, \nabla f_z]$$

An anisotropic modulus matrix μ can be obtained using the following equation 14.

[Equation 14]

$$\mu = [\nabla U_x, \nabla U_y, \nabla U_z^{-1}] [\nabla f_x, \nabla f_y, \nabla f_z]$$

The controller 13 calculates the shear modulus in accordance with the aforementioned method, and generates and outputs image data based on measured elastic wave signal $U=(U_x, U_y, U_z)$ and the calculated shear modulus μ .

According to the second method, since the shear modulus is calculated using a value ∇U_z of the elastic wave signal differentiated one time, an amplification level of noise is lowered. Accordingly, it is possible to obtain modulus image robust to noise. Also, since a modulus approximate to

an actual value is calculated using the iteration algorithm, it is possible to obtain exact modulus image.

The modulus image can be used to detect a focus by imaging the inside of a body or animal. Also, the modulus image can be applied to all the
5 fields for imaging the elastic wave.

As described above, the apparatus and method for imaging a shear modulus within a body in accordance with the present invention has the following advantages.

Since the shear modulus which minimizes noise is provided, it is
10 possible to reproduce image of high picture quality, which cannot be obtained from the existing MRI equipment or supersonic measurement device.

In addition, the modulus image of the present invention can be applied to the existing medical equipment. Accordingly, functional imaging can be provided to internal organs having different shear moduli, whereby
15 a new medical checkup technique can be achieved.

It will be apparent to those skilled in the art that various modifications and variations can be made in the present invention without departing from the spirit or scope of the inventions. Thus, it is intended that the present invention covers the modifications and
20 variations of this invention provided they come within the scope of the appended claims and their equivalents.

[CLAIMEDS]

1. A method for imaging a shear modulus, the method comprising:
generating an elastic wave inside an object to be measured;

5 detecting the elastic wave ongoing inside the object to be measured;
calculating a shear modulus of the inside of the object to be
measured, based on a value obtained by differentiating the detected
elastic wave one time; and

imaging the inside of the object to be measured, based on the
10 calculated shear modulus.

2. The method as claimed in claim 1, wherein the elastic wave is a
shear wave or a longitudinal wave.

3. The method as claimed in claim 1, wherein the step of calculating
a shear modulus of the inside of the object to be measured, based on a
15 value obtained by differentiating the detected elastic wave one time
includes:

calculating an irrotational component and a solenoidal component of
a stress vector from the detected elastic wave; and

calculating the shear modulus of the inside of the object to be
20 measured, using the calculated irrotational component and the calculated
solenoidal component, and the value obtained by differentiating the
detected elastic wave one time.

4. The method as claimed in claim 3, wherein the step of calculating
an irrotational component and a solenoidal component from the detected
25 elastic wave includes:

calculating the irrotational component using one directional component value of the detected elastic wave and a frequency of the elastic wave; and

calculating the solenoidal component based on the calculated
5 irrotational component and the value obtained by differentiating the detected elastic wave one time.

5. The method as claimed in claim 3, wherein in the step of calculating the shear modulus of the inside of the object to be measured, using the calculated irrotational component, the calculated solenoidal
10 component, and the value obtained by differentiating the detected elastic wave one time, the solenoidal component approximate to an actual value is calculated by applying the calculated irrotational component and the value obtained by differentiating the detected elastic wave one time to an iteration algorithm.

15 6. The method as claimed in claim 1, wherein the step of calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time includes:

calculating a three-directional irrotational component and a three-
20 directional solenoidal component of a stress vector from the detected elastic wave; and

calculating an anisotropic shear modulus of the inside of the object to be measured, using the calculated irrotational component, the calculated solenoidal component, and the value obtained by differentiating
25 the detected elastic wave one time.

7. The method as claimed in claim 6, wherein the step of calculating a three-directional irrotational component and a three-directional solenoidal component from the detected elastic wave includes:

5 calculating the three-directional irrotational component using a three-directional component value of the detected elastic wave and a frequency of the elastic wave; and

 calculating the three-directional solenoidal component based on the calculated three-directional irrotational component and the value obtained
10 by differentiating the detected elastic wave one time.

8. An apparatus for imaging a shear modulus, the apparatus comprising:

 an elastic wave generator generating an elastic wave inside an object to be measured;

15 a signal detector detecting the elastic wave ongoing inside the object to be measured; and

 a controller calculating a shear modulus of the inside of the object to be measured, based on a value obtained by differentiating the detected elastic wave one time, and imaging the inside of the object to be measured,
20 based on the calculated shear modulus.

9. The apparatus as claimed in claim 8, wherein the signal detector is MRI equipment or a supersonic measurement device.

10. The apparatus as claimed in claim 8, wherein the controller calculates an irrotational component and a solenoidal component of a
25 stress vector from the detected elastic wave, and calculates the shear

modulus of the inside of the object to be measured, using the calculated irrotational component, the calculated solenoidal component, and the value obtained by differentiating the detected elastic wave one time.

11. The apparatus as claimed in claim 10, wherein the controller
5 calculates the irrotational component using one directional component value of the detected elastic wave and a frequency of the elastic wave, and calculates the solenoidal component based on the calculated irrotational component and the value obtained by differentiating the detected elastic wave one time.

10 12. The apparatus as claimed in claim 10, wherein the controller calculates the solenoidal component approximate to an actual value by applying the calculated irrotational component and the value obtained by differentiating the detected elastic wave one time to an iteration algorithm.

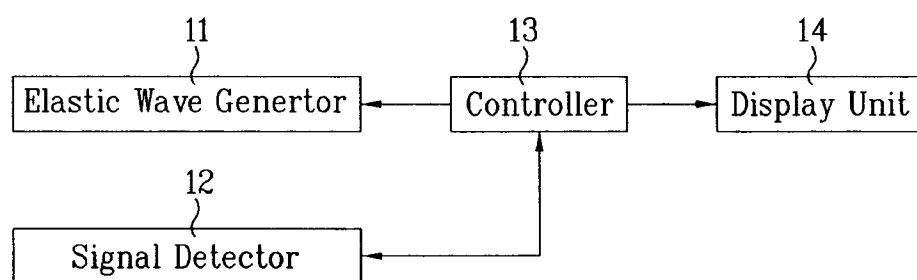
15 13. The apparatus as claimed in claim 10, wherein the controller calculates a three-directional irrotational component and a three-directional solenoidal component of a stress vector from the detected elastic wave, and calculates an anisotropic shear modulus of the inside of the object to be measured, using the calculated irrotational component,
20 the calculated solenoidal component, and the value obtained by differentiating the detected elastic wave one time.

14. The apparatus as claimed in claim 13, wherein the controller calculates the three-directional irrotational component using a three-
25 directional component value of the detected elastic wave and a frequency

of the elastic wave, and calculates the three-directional solenoidal component based on the calculated three-directional irrotational component and the value obtained by differentiating the detected elastic wave one time.

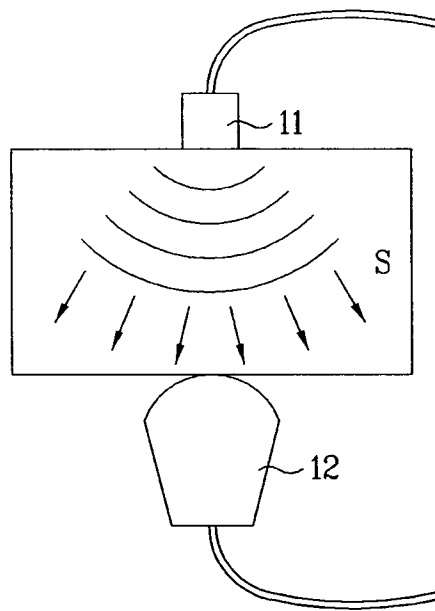
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FIG. 1



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FIG. 2



INTERNATIONAL SEARCH REPORT

International application No.
PCT/KR 2008/001921

A. CLASSIFICATION OF SUBJECT MATTER

IPC⁸: **A61B 8/08** (2006.01)

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC⁸: **A61B 8/08**

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)
WPI

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	US 2006/264736 A1 (EHMAN) 23 November 2006 (23.11.2006) <i>whole document</i>	1, 8
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A	JP 2003-210460 A (HITACHI) 29 July 2003 (29.07.2003) <i>whole document</i>	1, 8

☐ Further documents are listed in the continuation of Box C.☒ See patent family annex.

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Date of the actual completion of the international search
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Authorized officer

NARDAI F.

Telephone No. +43 / 1 / 534 24 / 347

INTERNATIONAL SEARCH REPORT

Information on patent family members

International application No.

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